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Fault Protected, Extended CMR, RS-485/RS-422 Transceivers with Cable Invert and ±16.5kV ESD

ISL32483E, ISL32485E

The <u>ISL32483E</u> and <u>ISL32485E</u> are fault protected, 5V powered differential transceivers that exceed the RS-485 and RS-422 standards for balanced communication. The RS-485 transceiver pins (driver outputs and receiver inputs) are fault protected up to ± 60 V and are protected against ± 16.5 kV ESD strikes without latch-up. Additionally, the extended common mode range allows these transceivers to operate in environments with common mode voltages up to ± 25 V (>2X the RS-485 requirement), making this fault-protected RS-485 family one of the most robust on the market.

Transmitters (Tx) deliver an exceptional 2.5V (typical) differential output voltage into the RS-485 specified 54Ω load. This yields better noise immunity than standard RS-485 ICs or allows up to six 120Ω terminations in star network topologies.

Receiver (Rx) inputs feature a "full fail-safe" design, which ensures a logic high Rx output if Rx inputs are floating, shorted, or on a terminated but undriven (idle) bus.

The ISL32483E and ISL32485E include cable invert functions that reverse the polarity of the Rx and/or Tx bus pins in case the cable is misconnected. Unlike competing devices, Rx full fail-safe operation is maintained even when the Rx input polarity is switched.

For fault protected RS-485 transceivers without the cable invert function, please see the <u>ISL32470E</u> and <u>ISL32490E</u> datasheets.

Features

- Fault protected RS-485 bus pins up to $\pm 60 \text{V}$
- Extended common mode range......±25V more than twice the range required for RS-485
- ±16.5kV HBM ESD protection on RS-485 bus pins
- Cable invert pins corrects for reversed cable connections while maintaining Rx full fail-safe functionality
- Full fail-safe (open, short, terminated) RS-485 receivers
- 1/4 Unit Load (UL) for up to 128 devices on the bus
- . High Rx IOI for opto-couplers in isolated designs
- Hot plug circuitry: Tx and Rx outputs remain three-state during power-up/power-down
- Slew rate limited RS-485 data rate 1Mbps
- Low quiescent supply current...... 2.3mA

Applications

- Utility meters/automated meter reading systems
- · High node count RS-485 systems
- PROFIBUS™ and RS-485 based field bus networks and factory automation
- · Security camera networks
- · Building lighting and environmental control systems
- · Industrial/process control networks

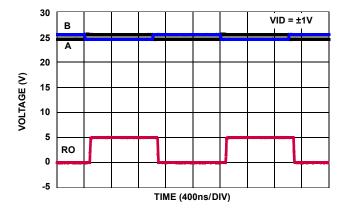


FIGURE 1. EXCEPTIONAL Rx OPERATES AT 1Mbps EVEN WITH ±25V COMMON MODE VOLTAGE

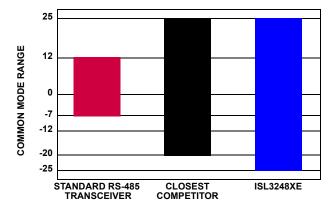


FIGURE 2. TRANSCEIVERS DELIVER SUPERIOR COMMON MODE RANGE vs STANDARD RS-485 DEVICES

TABLE 1. SUMMARY OF FEATURES

PART NUMBER	HALF/FULL DUPLEX	DATA RATE (Mbps)	SLEW-RATE LIMITED?	EN PINS?	HOT PLUG	POLARITY REVERSAL PINS?	QUIESCENT I _{CC} (mA)	LOW POWER SHDN?	PIN COUNT
ISL32483E	Full	1	Yes	Yes	Yes	Yes	2.3	Yes	14
ISL32485E	Half	1	Yes	Tx Only	Yes	Yes	2.3	No	8

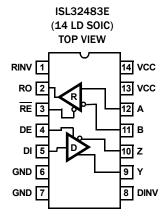
Ordering Information

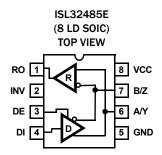
PART NUMBER (Notes 1, 2, 3)	PART MARKING	TEMP. RANGE (°C)	PACKAGE (RoHS Compliant)	PKG. DWG. #	
ISL32483EIBZ	ISL32483 EIBZ	-40 to +85	14 Ld SOIC	M14.15	
ISL32485EIBZ	32485 EIBZ	-40 to +85	8 Ld SOIC	M8.15	

NOTES:

- 1. Add "-T*" suffix for tape and reel. Please refer to TB347 for details on reel specifications.
- 2. These Intersil Pb-free plastic packaged products employ special Pb-free material sets, molding compounds/die attach materials, and 100% matte tin plate plus anneal (e3 termination finish, which is RoHS compliant and compatible with both SnPb and Pb-free soldering operations). Intersil Pb-free products are MSL classified at Pb-free peak reflow temperatures that meet or exceed the Pb-free requirements of IPC/JEDEC J STD-020.
- 3. For Moisture Sensitivity Level (MSL), please see device information page for ISL32483E and ISL32485E. For more information on MSL please see techbrief IB363.

Pin Configurations





Pin Descriptions

PIN NAME	ISL32483E PIN#	ISL32485E PIN#	DESCRIPTION
RO	2	1	Receiver output. If INV or RINV is low, then: If $A - B \ge -10$ mV, RO is high; if $A - B \le -200$ mV, RO is low. If INV or RINV is high, then: If $B - A \ge -10$ mV, RO is high; if $B - A \le -200$ mV, RO is low. In all cases, RO = High if A and B are unconnected (floating) or shorted together or connected to an undriven, terminated bus (i.e., Rx is always fail safe open, shorted and idle even if polarity is inverted).
RE	3	-	Receiver output enable. RO is enabled when \overline{RE} is low; RO is high impedance when \overline{RE} is high. Internally pulled low.
DE	4	3	Driver output enable. The driver outputs, Y and Z, are enabled by bringing DE high and they are high impedance when DE is low. Internally pulled high to V _{CC} .
DI	5	4	Driver input. If INV or DINV is low, a low on DI forces output Y low and output Z high, while a high on DI forces output Y high and output Z low. The output states relative to DI invert if INV or DINV is high.
GND	6, 7	5	Ground connection.
A/Y	-	6	± 60 V Fault and ± 16.5 kV HBM ESD Protected RS-485/RS-422 level I/O pin. If INV is low than, A/Y is the noninverting receiver input and noninverting driver output. If INV is high, than A/Y is the inverting receiver input and the inverting driver output. Pin is an input if DE = 0; pin is an output if DE = 1.
B/Z	-	7	± 60 V Fault and ± 16.5 kV HBM ESD Protected RS-485/RS-422 level I/O pin. If INV is low, than B/Z is the inverting receiver input and inverting driver output. If INV is high, than B/Z is the noninverting receiver input and the noninverting driver output. Pin is an input if DE = 0; pin is an output if DE = 1.
Α	12	-	±60V Fault and ±15kV HBM ESD Protected RS-485/RS-422 level input. If RINV is low, then A is the noninverting receiver input. If RINV is high, then A is the inverting receiver input.
В	11	-	±60V Fault and ±15kV HBM ESD Protected RS-485/RS-422 level input. If RINV is low, then B is the inverting receiver input. If RINV is high, then B is the noninverting receiver input.
Υ	9	-	±60V Fault and ±15kV HBM ESD Protected RS-485/RS-422 level output. If DINV is low, then Y is the noninverting driver output. If DINV is high, then Y is the inverting driver output
Z	10	-	± 60 V Fault and ± 15 kV HBM ESD Protected RS-485/RS-422 level. If DINV is low, then Z is the inverting driver output. If DINV is high, then Z is the noninverting driver output.
VCC	13, 14	8	System power supply input (4.5V to 5.5V).
INV	-	2	Receiver and driver polarity selection input. When driven high, this pin swaps the polarity of the driver output and receiver input pins. If unconnected (floating) or connected low, normal RS-485 polarity conventions apply. Internally pulled low.
RINV	1	-	Receiver polarity selection input. When driven high, this pin swaps the polarity of the receiver input pins. If unconnected (floating) or connected low, normal RS-485 polarity conventions apply. Internally pulled low.
DINV	8	-	Driver polarity selection input. When driven high, this pin swaps the polarity of the driver output pins. If unconnected (floating) or connected low, normal RS-485 polarity conventions apply. Internally pulled low.

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Truth Tables

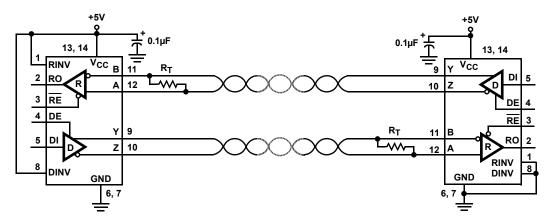
TRANSMITTING							
	INPUTS				PUTS		
RE	DE	DI	INV or DINV	Y	Z		
х	1	1	0	1	0		
х	1	0	0	0	1		
х	1	1	1	0	1		
х	1	0	1	1	0		
0	0	х	Х	High-Z	High-Z		
1	0	Х	Х	High-Z (see Note)	High-Z (see Note)		

NOTE: Low Power Shutdown Mode (see $\underline{\text{Note 11}}$ on $\underline{\text{page 7}}$), except for ISL32485E.

	RECEIVING								
		INPUTS			OUTPUT				
RE	DE (Half Duplex)	DE (Full Duplex)	А-В	INV or RINV	RO				
0	0	х	≥ -0.01V	0	1				
0	0	х	≤ -0.2V	0	0				
0	0	х	≤ 0.01V	1	1				
0	0	х	≥ 0.2V	1	0				
0	0	Х	Inputs Open or Shorted	х	1				
1	0	0	Х	Х	High-Z (see Note)				
1	1	1	Х	х	High-Z				

NOTE: Low Power Shutdown Mode (see <u>Note 11</u> on <u>page 7</u>), except for ISL32485E.

Typical Operating Circuits



THE IC ON THE LEFT HAS THE CABLE CONNECTIONS SWAPPED, SO THE INV PINS (1, 8) ARE STRAPPED HIGH TO INVERT ITS Rx AND Tx POLARITY

FIGURE 3. ISL32483E FULL DUPLEX EXAMPLE

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Absolute Maximum Ratings

V _{CC} to Ground
Input Voltages
DI, INV, RINV, DINV, DE, RE
Input/Output Voltages
A/Y, B/Z, A, B, Y, Z
A/Y, B/Z, A, B, Y, Z (Transient Pulse Through 100Ω , see Note 15) $\pm 80V$
RO0.3V to (V _{CC} +0.3V)
Short-circuit Duration
Y, Z Indefinite
ESD Rating see <u>"ESD PERFORMANCE" on page 6</u>
Latch-up (Tested per JESD78, Level 2, Class A) +125°C

Thermal Information

Thermal Resistance (Typical)	θ_{JA} (°C/W)	θ_{JC} (°C/W)
8 Ld SOIC Package (Notes 4, 5)	104	47
14 Ld SOIC Package (Notes 4, 5)	78	42
Maximum Junction Temperature (Plastic Pac	kage)	+150°C
Maximum Storage Temperature Range	65	5°C to +150°C
Pb-free Reflow Profile		see <u>TB493</u>

Recommended Operating Conditions

Supply Voltage (V _{CC})	5٧
Temperature Range40°C to +85	5°C
Bus Pin Common Mode Voltage Range25V to +2	25V

CAUTION: Do not operate at or near the maximum ratings listed for extended periods of time. Exposure to such conditions may adversely impact product reliability and result in failures not covered by warranty.

NOTES:

- 4. θ_{JA} is measured with the component mounted on a high effective thermal conductivity test board in free air. See Tech Brief TB379 for details.
- 5. For $\theta_{\mbox{\scriptsize JC}},$ the "case temp" location is taken at the package top center.

Electrical Specifications Test Conditions: $V_{CC} = 4.5V$ to 5.5V; Unless Otherwise Specified. Typicals are at $V_{CC} = 5V$, $T_A = +25$ °C (Note 6). Boldface limits apply across the operating temperature range, -40°C to +85°C.

PARAMETER	SYMBOL	TEST CONDITIONS	TEMP (°C)	MIN (<u>Note 14</u>)	TYP	MAX (Note 14)	UNIT
DC CHARACTERISTICS							
Driver Differential V _{OUT} (No load)	V _{OD1}		Full	-	-	V _{CC}	V
Driver Differential V _{OUT}	V _{OD2}	R _L = 100Ω (RS-422)	Full	2.4	3.2	-	٧
(Loaded, <u>Figure 4A</u>)		$R_L = 54\Omega (RS-485)$	Full	1.5	2.5	v _{cc}	V
		$R_L = 54\Omega (PROFIBUS, V_{CC} \ge 5V)$	Full	2.0	2.5	-	V
		R_L = 21Ω (Six 120Ω terminations for Star Configurations, $V_{CC} \ge 4.75V$)	Full	0.8	1.3	-	V
Change in Magnitude of Driver Differential V _{OUT} for Complementary Output States	ΔV _{OD}	R_L = 54Ω or 100Ω (Figure 4A)	Full	-	-	0.2	V
Driver Differential V _{OUT} with	V _{OD3}	$R_L = 60\Omega$, $-7V \le V_{CM} \le 12V$	Full	1.5	2.1	V _{CC}	V
Common Mode Load (Figure 4B)		$R_L = 60\Omega, -25V \le V_{CM} \le 25V (V_{CC} \ge 4.75V)$	Full	1.7	2.3		V
(<u>rigure 4b</u>)		$R_L = 21\Omega, -15V \le V_{CM} \le 15V (V_{CC} \ge 4.75V)$	Full	0.8	1.1	-	V
Driver Common Mode V _{OUT}	V _{oc}	$R_L = 54\Omega$ or 100Ω	Full	-1	-	3	V
(<u>Figure 4</u>)		$R_L = 60\Omega$ or 100Ω , $-20V \le V_{CM} \le 20V$	Full	-2.5	-	5	V
Change in Magnitude of Driver Common Mode V _{OUT} for Complementary Output States	DV _{OC}	R_L = 54Ω or 100Ω (Figure 4A)	Full	-	-	0.2	V
Driver Short-circuit Current	losp	DE = V _{CC} , -25V ≤ V ₀ ≤ 25V (<u>Note 8</u>)	Full	-250	-	250	mA
	I _{OSD1}	At First fold-back, 22V ≤ V ₀ ≤ -22V	Full	-83	-	83	mA
	I _{OSD2}	At Second fold-back, 35V ≤ V ₀ ≤ -35V	Full	-13	-	13	mA
Logic Input High Voltage	V _{IH}	DE, DI, RE, INV, RINV, DINV	Full	2.5	-	-	٧
Logic Input Low Voltage	V_{IL}	DE, DI, RE, INV, RINV, DINV	Full	-	-	0.8	٧
Logic Input Current	I _{IN1}	DI	Full	-1	-	1	μΑ
		DE, RE, INV, RINV, DINV	Full	-15	6	15	μΑ

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Electrical Specifications Test Conditions: $V_{CC} = 4.5V$ to 5.5V; Unless Otherwise Specified. Typicals are at $V_{CC} = 5V$, $T_A = +25 \,^{\circ}C$ (Note 6). Boldface limits apply across the operating temperature range, -40 $^{\circ}C$ to +85 $^{\circ}C$. (Continued)

PARAMETER	SYMBOL	TEST CO	NDITIONS	TEMP (°C)	MIN (<u>Note 14</u>)	TYP	MAX (<u>Note 14</u>)	UNIT
Input/Output Current (A/Y,	I _{IN2}	DE = OV,	V _{IN} = 12V	Full	-	110	250	μΑ
B/Z)		$V_{CC} = 0V \text{ or } 5.5V$	V _{IN} = -7V	Full	-200	-75	•	μΑ
			V _{IN} = ±25V	Full	-800	±240	800	μΑ
			V _{IN} = ±60V (<u>Note 17</u>)	Full	-6	±0.7	6	mA
Input Current (A, B)	I _{IN3}	3 V _{CC} = 0V or 5.5V	V _{IN} = 12V	Full	-	90	125	μΑ
(Full Duplex Versions Only)			V _{IN} = -7V	Full	-100	-70	-	μΑ
			V _{IN} = ±25V	Full	-500	±200	500	μΑ
			V _{IN} = ±60V (<u>Note 17</u>)	Full	-3	±0.5	3	mA
Output Leakage Current (Y, Z)	I _{OZD}	$\overline{RE} = 0V$, $DE = 0V$,	V _{IN} = 12V	Full	•	20	200	μΑ
(Full Duplex Versions Only)		$V_{CC} = 0V \text{ or } 5.5V$	V _{IN} = -7V	Full	-100	-5	•	μΑ
			V _{IN} = ±25V	Full	-500	±40	500	μΑ
			V _{IN} = ±60V (<u>Note 17</u>)	Full	-3	±0.15	3	mA
Receiver Differential Threshold Voltage	V _{TH}	A-B if INV or RINV = 0; B-A if INV or RINV = 1, $-25V \le V_{CM} \le 25V$		Full	-200	-100	-10	mV
Receiver Input Hysteresis	DV _{TH}	-25V ≤ V _{CM} ≤ 25V		25	-	25	-	mV
Receiver Output High Voltage	V _{OH}	V _{ID} = -10mV	I ₀ = -2mA	Full	V _{CC} - 0.5	4.75	•	V
			I ₀ = -8mA	Full	2.8	4.2		V
Receiver Output Low Voltage	V _{OL}	I _O = 6mA, V _{ID} = -200mV		Full	-	0.27	0.4	V
Receiver Output Low Current	I _{OL}	V ₀ = 1V, V _{ID} = -200mV		Full	15	22	•	mA
Three-state (High Impedance) Receiver Output Current	lozr	0V ≤ V ₀ ≤ V _{CC} (<u>Note 16</u>)			-1	0.01	1	μΑ
Receiver Short-circuit Current	Iosr	$0V \le V_O \le V_{CC}$		Full	±12	-	±110	mA
SUPPLY CURRENT								
No-load Supply Current (Note 7)	Icc	$DE = V_{CC}, \overline{RE} = 0V \text{ or } V_{CC}$	V_{CC} , DI = OV or V_{CC}	Full	-	2.3	4.5	mA
Shutdown Supply Current	I _{SHDN}	$DE = OV, \overline{RE} = V_{CC}, DI$	= 0V or V _{CC} (<u>Note 16</u>)	Full	-	10	50	μΑ
ESD PERFORMANCE								
RS-485 Pins (A, Y, B, Z, A/Y,		Human Body Model,	1/2 Duplex	25	-	±16.5	-	kV
B/Z)		From Bus Pins to GND	Full Duplex	25	-	±15	-	kV
All Pins		Human Body Model, p	er JEDEC	25	-	±8	-	kV
		Machine Model		25	-	±700	-	V
DRIVER SWITCHING CHARACTI	ERISTICS							
Driver Differential Output	t _{PLH} , t _{PHL}	$R_D = 54\Omega$, $C_D = 50pF$	No CM load	Full	•	70	125	ns
Delay		(<u>Figure 5</u>)	-25V ≤ V _{CM} ≤ 25V	Full	-	-	350	ns
Driver Differential Output	tskew	$R_D = 54\Omega, C_D = 50pF$	No CM Load	Full	•	4.5	15	ns
Skew		(<u>Figure 5</u>)	-25V ≤ V _{CM} ≤ 25V (<u>Note 18</u>)	Full	-	-	25	ns
Driver Differential Rise or Fall	t _R , t _F	$R_D = 54\Omega, C_D = 50pF$	No CM Load	Full	70	170	300	ns
Time		(<u>Figure 5</u>)	-25V ≤ V _{CM} ≤ 25V	Full	70	-	550	ns
Maximum Data Rate	f _{MAX}	C _D = 820pF (<u>Figure 7</u>))	Full	1	4	-	Mbps
Driver Enable to Output High	t _{ZH}	SW = GND (<u>Figure 6</u>),	(<u>Note 9</u>)	Full	-	-	350	ns
Driver Enable to Output Low	t _{ZL}	SW = V_{CC} (<u>Figure 6</u>), (Note 9)	Full	•	-	300	ns

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Electrical Specifications Test Conditions: $V_{CC} = 4.5V$ to 5.5V; Unless Otherwise Specified. Typicals are at $V_{CC} = 5V$, $T_A = +25^{\circ}C$ (Note 6). Boldface limits apply across the operating temperature range, -40°C to +85°C. (Continued)

PARAMETER SYMBOL		TEST CONDITIONS	TEMP (°C)	MIN (<u>Note 14</u>)	ТҮР	MAX (<u>Note 14</u>)	UNIT
Driver Disable from Output Low	t _{LZ}	SW = V _{CC} (<u>Figure 6</u>)	Full	-	-	120	ns
Driver Disable from Output High	t _{HZ}	SW = GND (<u>Figure 6</u>)	Full	-	-	120	ns
Time to Shutdown	tSHDN	(Notes 11, 16)	Full	60	160	600	ns
Driver Enable from Shutdown to Output High	t _{ZH(SHDN)}	SW = GND (Figure 6), (Notes 11, 12, 16)	Full	-	-	2000	ns
Driver Enable from Shutdown to Output Low	t _{ZL(SHDN)}	SW = V _{CC} (Figure 6), (Notes 11, 12, 16)	Full	-	-	2000	ns
RECEIVER SWITCHING CHARAC	CTERISTICS				I	1	l
Maximum Data Rate	f _{MAX}	-25V ≤ V _{CM} ≤ 25V (<u>Figure 8</u>)	Full	1	15	-	Mbps
Receiver Input to Output Delay	t _{PLH} , t _{PHL}	-25V ≤ V _{CM} ≤ 25V (<u>Figure 8</u>)	Full	-	90	150	ns
Receiver Skew t _{PLH} - t _{PHL}	t _{SKD}	(Figure 8)	Full	-	4	10	ns
Receiver Enable to Output Low	t _{ZL}	$R_L = 1k\Omega$, $C_L = 15pF$, $SW = V_{CC}$ (Figure 9), (Notes 10, 16)	Full	-	-	50	ns
Receiver Enable to Output High	t _{ZH}	$R_L = 1k\Omega$, $C_L = 15pF$, $SW = GND$ (Figure 9), (Notes 10, 16)	Full	-	-	50	ns
Receiver Disable from Output Low	t _{LZ}	$R_L = 1k\Omega$, $C_L = 15pF$, $SW = V_{CC}$ (Figure 9) (Note 16)	Full	-	-	50	ns
Receiver Disable from Output High	t _{HZ}	$R_L = 1k\Omega$, $C_L = 15pF$, $SW = GND$ (Figure 9) (Note 16)	Full	-	-	50	ns
Time to Shutdown	t _{SHDN}	(Notes 11, 16)	Full	60	160	600	ns
Receiver Enable from Shutdown to Output High	t _{ZH(SHDN)}	$R_L = 1k\Omega$, $C_L = 15pF$, $SW = GND$ (Figure 9), (Notes 11, 13, 16)	Full	-	-	2000	ns
Receiver Enable from Shutdown to Output Low	tzl(SHDN)	$\begin{aligned} &R_L = 1 \text{k}\Omega, C_L = 15 \text{pF, SW} = \text{V}_{CC} \left(\underline{\text{Figure 9}} \right), \\ &\left(\underline{\text{Notes 11, 13, 16}} \right) \end{aligned}$	Full	•	-	2000	ns

NOTES:

- All currents into device pins are positive; all currents out of device pins are negative. All voltages are referenced to device ground unless otherwise specified.
- 7. Supply current specification is valid for loaded drivers when DE = 0V.
- 8. Applies to peak current. See "Typical Performance Curves" beginning on page 13 for more information.
- 9. Keep $\overline{RE} = 0$ to prevent the device from entering SHDN.
- 10. The RE signal high time must be short enough (typically <100ns) to prevent the device from entering SHDN.
- 11. Transceivers (except on the ISL32485E) are put into shutdown by bringing RE high and DE low. If the inputs are in this state for less than 60ns, the parts are guaranteed not to enter shutdown. If the inputs are in this state for at least 600ns, the parts are guaranteed to have entered shutdown. See "Low Power Shutdown Mode" on page 12,
- 12. Keep \overline{RE} = VCC and set the DE signal low time >600ns to ensure that the device enters SHDN.
- 13. Set the RE signal high time >600ns to ensure that the device enters SHDN.
- 14. Compliance to data sheet limits is assured by one or more methods: production test, characterization and/or design.
- 15. Tested according to TIA/EIA-485-A, Section 4.2.6 (±80V for 15ms at a 1% duty cycle).
- 16. Does not apply to the ISL32485E. The ISL32485E has no Rx enable function and thus no SHDN function.
- 17. See "Caution" statement in the "Recommended Operating Conditions" on page 5.
- 18. This parameter is not production tested.

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Test Circuits and Waveforms

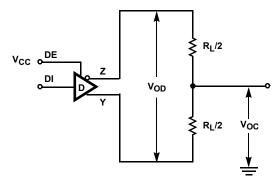


FIGURE 4A. V_{OD} AND V_{OC}

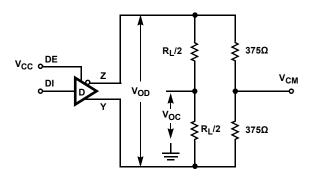
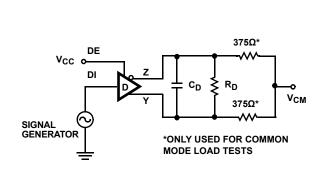


FIGURE 4B. $\,\mathrm{V_{OD}}\,\mathrm{AND}\,\mathrm{V_{OC}}\,\mathrm{WITH}\,\mathrm{COMMON}\,\mathrm{MODE}\,\mathrm{LOAD}$

FIGURE 4. DC DRIVER TEST CIRCUITS



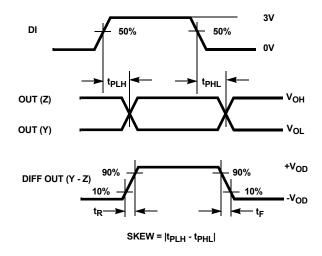
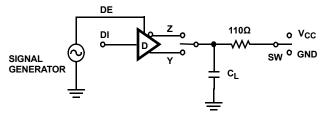


FIGURE 5A. TEST CIRCUIT

FIGURE 5B. MEASUREMENT POINTS

FIGURE 5. DRIVER PROPAGATION DELAY AND DIFFERENTIAL TRANSITION TIMES



PARAMETER	OUTPUT	RE	DI	sw	C _L (pF)
t _{HZ}	Y/Z	Х	1/0	GND	50
t _{LZ}	Y/Z	Х	0/1	v _{cc}	50
t _{ZH}	Y/Z	0 (<u>Note 9</u>)	1/0	GND	100
t _{ZL}	Y/Z	0 (<u>Note 9</u>)	0/1	v _{cc}	100
t _{ZH(SHDN)}	Y/Z	1 (<u>Note 12</u>)	1/0	GND	100
t _{ZL(SHDN)}	Y/Z	1 (<u>Note 12</u>)	0/1	v _{cc}	100

3V 50% (Note 11 0V tzh, tzh(SHDN) — → t_H; OUTPUT HIGH tHZ (Note 11) V_{OH} V_{OH} - 0.5V OUT (Y, Z) 0V tzl, tzl(SHDN) tLZ (Note 11 v_{cc} OUT (Y, Z) V_{OL} OUTPUT LOW

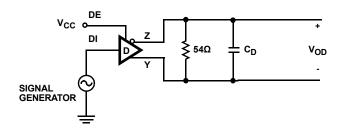
FIGURE 6A. TEST CIRCUIT

FIGURE 6B. MEASUREMENT POINTS

FIGURE 6. DRIVER ENABLE AND DISABLE TIMES

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Test Circuits and Waveforms (Continued)



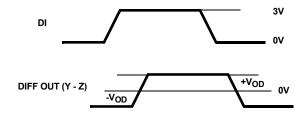
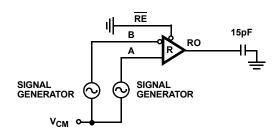


FIGURE 7A. TEST CIRCUIT

FIGURE 7B. MEASUREMENT POINTS

FIGURE 7. DRIVER DATA RATE



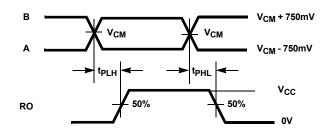
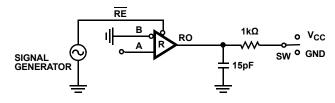


FIGURE 8A. TEST CIRCUIT

FIGURE 8B. MEASUREMENT POINTS

FIGURE 8. RECEIVER PROPAGATION DELAY AND DATA RATE



PARAMETER	DE	A	sw
t _{HZ}	0	+1.5V	GND
t _{LZ}	0	-1.5V	V _{CC}
t _{ZH} (<u>Note 10</u>)	0	+1.5V	GND
t _{ZL} (<u>Note 10</u>)	0	-1.5V	v _{cc}
t _{ZH(SHDN)} (Note 13)	0	+1.5V	GND
t _{ZL(SHDN)} (Note 13)	0	-1.5V	v _{cc}

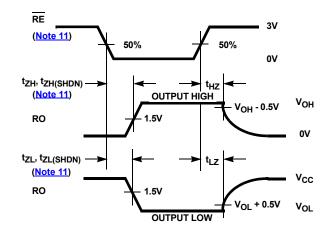


FIGURE 9A. TEST CIRCUIT

FIGURE 9B. MEASUREMENT POINTS

FIGURE 9. RECEIVER ENABLE AND DISABLE TIMES

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Application Information

RS-485 and RS-422 are differential (balanced) data transmission standards used for long haul or noisy environments. RS-422 is a subset of RS-485, so RS-485 transceivers are also RS-422 compliant. RS-422 is a point-to-multipoint (multidrop) standard, which allows only one driver and up to 10 (assuming one-unit load devices) receivers on each bus. RS-485 is a true multipoint standard, which allows up to 32 one-unit load devices (any combination of drivers and receivers) on each bus. To allow for multipoint operation, the RS-485 specification requires that drivers must handle bus contention without sustaining any damage.

Another important advantage of RS-485 is the extended Common Mode Range (CMR), which specifies that the driver outputs and receiver inputs withstand signals that range from +12V to -7V. RS-422 and RS-485 are intended for runs as long as 4000 feet, so the wide CMR is necessary to handle ground potential differences, as well as voltages induced in the cable by external fields.

The ISL3248xE is a family of ruggedized RS-485 transceivers that improves on the RS-485 basic requirements and therefore increases system reliability. The CMR increases to ± 25 V, while the RS-485 bus pins (receiver inputs and driver outputs) include fault protection against voltages and transients up to ± 60 V. Additionally, larger-than-required differential output voltages (VOD) increase noise immunity, while the ± 16.5 kV built-in ESD protection complements the fault protection.

Receiver (Rx) Features

These devices utilize a differential input receiver for maximum noise immunity and common mode rejection. Input sensitivity is better than ± 200 mV, as required by the RS-422 and RS-485 specifications.

Receiver input (load) current surpasses the RS-422 specification of 3mA and is four times lower than the RS-485 "Unit Load (UL)" requirement of 1mA maximum. Thus, these products are known as "one-quarter UL" transceivers and there can be up to 128 of these devices on a network while still complying with the RS-485 loading specification.

The Rx functions with common mode voltages as great as ±25V, making them ideal for industrial or long networks where induced voltages are a realistic concern.

All the receivers include a "full fail-safe" function that guarantees a high-level receiver output if the receiver inputs are unconnected (floating), shorted together or connected to a terminated bus with all the transmitters disabled (i.e., an idle bus).

Rx outputs feature high drive levels (typically 22mA at V_{OL} = 1V) to ease the design of optically coupled isolated interfaces. Except for the ISL32485E, Rx outputs are three-statable via the active low $\overline{\text{RE}}$ input.

The Rx includes noise filtering circuitry to reject high frequency signals and typically rejects pulses narrower than 50ns (equivalent to 20Mbps).

Driver (Tx) Features

The RS-485/RS-422 driver is a differential output device that delivers at least 1.5V across a 54Ω load (RS-485) and at least 2.4V across a 100Ω load (RS-422). The drivers feature low propagation delay skew to maximize bit width and to minimize EMI. Thus, all drivers are three-statable via the active high DE input.

The driver outputs are slew rate limited to minimize EMI and to minimize reflections in unterminated or improperly terminated networks.

High Overvoltage (Fault) Protection Increases Ruggedness

The $\pm 60V$ (referenced to the IC GND) fault protection on the RS-485 pins makes these transceivers some of the most rugged on the market. This level of protection makes the ISL3248xE perfect for applications where power (e.g., 24V and 48V supplies) must be routed in the conduit with the data lines or for outdoor applications where large transients are likely to occur. When power is routed with the data lines, even a momentary short between the supply and data lines will destroy an unprotected device. The $\pm 60V$ fault levels of this family are at least 5x higher than the levels specified for standard RS-485 ICs. The ISL3248xE protection is active whether the Tx is enabled or disabled and even if the IC is powered down.

If transients or voltages (including overshoots and ringing) greater than $\pm 60V$ are possible, then additional external protection is required.

Widest Common Mode Voltage (CMV) Tolerance Improves Operating Range

The RS-485 networks operating in industrial complexes or over long distances are susceptible to large CMV variations. Either of these operating environments may suffer from large node-to-node ground potential differences or CMV pickup from external electromagnetic sources and devices with only the minimum required +12V to -7V CMR may malfunction. The ISL3248xE's extended ± 25 V CMR is the widest available, allowing operation in environments that would overwhelm lesser transceivers. Additionally, the Rx will not phase invert (erroneously change state), even with CMVs of ± 40 V or differential voltages as large as 40V.

Cable Invert (Polarity Reversal) Function

With large node count RS-485 networks, it is common for some cable data lines to be wired backwards during installation. When this happens, the node is unable to communicate over the network. Once a technician finds the miswired node, the connector must be rewired, which is time consuming.

The ISL32483E and ISL32485E simplify this task by including cable invert pins (INV, DINV, RINV) that allow the technician to invert the polarity of the Rx input and/or the Tx output pins simply by moving a jumper to change the state of the invert pins. When the invert pin is low, the IC operates like any standard RS-485 transceiver and the bus pins have their normal polarity definition of A and Y being noninverting and B and Z being inverting. With the invert pin high, the corresponding bus pins reverse their polarity, so B and Z are now noninverting and A and Y become inverting.

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Intersil's unique cable invert function is superior to that found on competing devices because the Rx full fail-safe function is maintained, even when the Rx polarity is reversed. Competitor devices implement the Rx invert function simply by inverting the Rx output. This means that with the Rx inputs floating or shorted together, the Rx appropriately delivers a logic 1 in normal polarity, but outputs a logic low when the IC is operated in the inverted mode. Intersil's innovative Rx design guarantees that, with the Rx inputs floating or shorted together ($V_{\text{ID}} = OV$), the Rx output remains high, regardless of the state of the invert pins.

The full duplex ISL32483E includes two invert pins that allow for separate control of the Rx and Tx polarities. If only the Rx cable is miswired, then only the RINV pin need be driven to a logic 1. If the Tx cable is miswired, then DINV must be connected to a logic high. The half-duplex version has only one logic pin (INV) that, when high, switches the polarity of both the Tx and the Rx blocks.

High V_{OD} Improves Noise Immunity and Flexibility

The ISL3248xE driver design delivers larger differential output voltages (V $_{OD}$) than the RS-485 standard requirements or than most RS-485 transmitters can deliver. The typical $\pm 2.5 \text{V}_{OD}$ provides more noise immunity than networks built using many other transceivers.

Another advantage of the large V_{OD} is the ability to drive more than two bus terminations, which allows for utilizing the ISL3248xE in "star" and other multi-terminated, nonstandard network topologies.

Figure 11 on page 13 details the transmitter's V_{OD} versus I_{OUT} characteristic and includes load lines for four (30Ω) and six (20Ω) 120 Ω terminations. Figure 11 shows that the driver typically delivers ± 1.3 V into six terminations and the "Electrical Specifications" on page 5 guarantees a V_{OD} of ± 0.8 V at 21Ω over the full temperature range. The RS-485 standard requires a minimum 1.5V V_{OD} into two terminations, but the ISL3248xE delivers RS-485 voltage levels with 2x to 3x the number of terminations.

Hot Plug Function

When a piece of equipment powers up, there is a period of time in which the processor or ASIC driving the RS-485 control lines (DE, $\overline{\text{RE}}$) is unable to ensure that the RS-485 Tx and Rx outputs are kept disabled. If the equipment is connected to a bus, a driver activating prematurely during power-up may crash the bus. To avoid this scenario, the ISL3248xE devices incorporate a "Hot Plug" function. Circuitry monitoring VCC ensures that, during power-up and power-down, the Tx and Rx outputs remain disabled, regardless of the state of DE and $\overline{\text{RE}}$, if VCC is less than $\approx 3.5 \text{V}$. This gives the processor or ASIC a chance to stabilize and drive the RS-485 control lines to the proper states. Figure 10 illustrates the power-up and power-down performance of the ISL3248xE compared to an RS-485 IC without the Hot Plug feature.

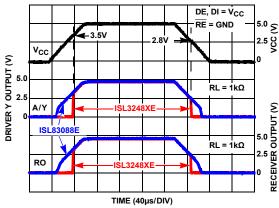


FIGURE 10. HOT PLUG PERFORMANCE (ISL3248XE) vs ISL83088E
WITHOUT HOT PLUG CIRCUITRY

ESD Protection

All pins on the ISL3248xE devices include Class 3 (>8kV) Human Body Model (HBM) ESD protection structures that are good enough to survive ESD events commonly seen during manufacturing. Even so, the RS-485 pins (driver outputs and receiver inputs) incorporate more advanced structures that allow them to survive ESD events in excess of ±16.5kV HBM (±15kV for full-duplex version). The RS-485 pins are particularly vulnerable to ESD strikes, because they typically connect to an exposed port on the exterior of the finished product. Simply touching the port pins or connecting a cable can cause an ESD event that might destroy unprotected ICs. The new ESD structures protect the device whether or not it is powered up and without interfering with the exceptional ±25V CMR. This built-in ESD protection minimizes the need for board-level protection structures (e.g., transient suppression diodes) and the associated, undesirable capacitive load they present.

Data Rate, Cables and Terminations

The RS-485/RS-422 are intended for network lengths up to 4000 feet, but the maximum system data rate decreases as the transmission length increases. These 1Mbps versions can operate at full data rates with lengths up to 800 ft. (244m). Jitter is the limiting parameter at this data rate, so employing encoded data streams (e.g., Manchester coded or Return-to-Zero) may allow increased transmission distances.

Twisted pair is the cable of choice for RS-485/RS-422 networks. Twisted pair cables tend to pick up noise and other electromagnetically induced voltages as common mode signals, which are effectively rejected by the differential receivers in these ICs.

Proper termination is imperative to minimize reflections and terminations are recommended unless power dissipation is an overriding concern. In point-to-point, or point-to-multipoint (single driver on bus like RS-422) networks, the main cable should be terminated in its characteristic impedance (typically 120Ω) at the end farthest from the driver. In multireceiver applications, stubs connecting receivers to the main cable should be kept as short as possible. Multipoint (multidriver) systems require that the main cable be terminated in its characteristic impedance at both ends. Stubs connecting a transceiver to the main cable should be kept as short as possible.

Built-in Driver Overload Protection

As stated previously, the RS-485 specification requires that drivers survive worst-case bus contentions undamaged. These transceivers meet this requirement via driver output short-circuit current limits and on-chip thermal shutdown circuitry.

The driver output stages incorporate a double foldback, short-circuit current limiting scheme, which ensures that the output current never exceeds the RS-485 specification, even at the common mode and fault condition voltage range extremes. The first foldback current level ($\approx 70 \text{mA}$) is set to ensure that the driver never folds back when driving loads with common mode voltages up to $\pm 25 \text{V}$. The very low second foldback current setting ($\approx 9 \text{mA}$) minimizes power dissipation if the Tx is enabled when a fault occurs.

In the event of a major short-circuit condition, devices also include a thermal shutdown feature that disables the drivers whenever the die temperature becomes excessive. This eliminates the power dissipation, allowing the die to cool. The drivers automatically re-enable after the die temperature drops about 15 °C. If the contention persists, the thermal shutdown/reenable cycle repeats until the fault is cleared. Receivers stay operational during thermal shutdown.

Low Power Shutdown Mode

These BiCMOS transceivers all use a fraction of the power required by competitive devices, but they also include a shutdown feature (except the ISL32485E) that reduces the already low quiescent I_{CC} to a $10\mu A$ trickle. These devices enter shutdown whenever the receiver and driver are simultaneously disabled (\overline{RE} = V_{CC} and DE = GND) for a period of at least 600ns. Disabling both the driver and the receiver for less than 60ns guarantees that the transceiver will not enter shutdown.

Note that receiver and driver enable times increase when the transceiver enables from shutdown. Refer to Notes 9, 10, 11, 12 and 13, at the end of "Electrical Specifications" on page 5, for more information.

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Typical Performance Curves $v_{CC} = 5v$, $T_A = +25$ °C; Unless Otherwise Specified.

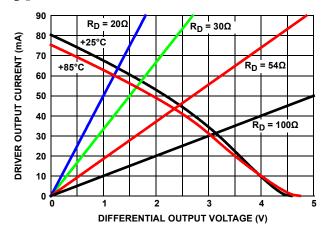


FIGURE 11. DRIVER OUTPUT CURRENT vs DIFFERENTIAL OUTPUT VOLTAGE

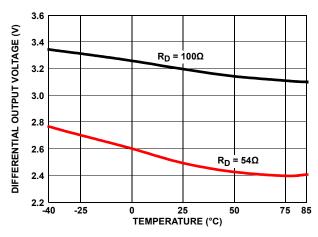


FIGURE 12. DRIVER DIFFERENTIAL OUTPUT VOLTAGE vs TEMPERATURE

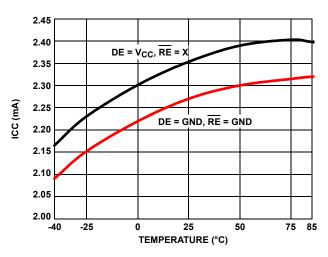


FIGURE 13. SUPPLY CURRENT vs TEMPERATURE

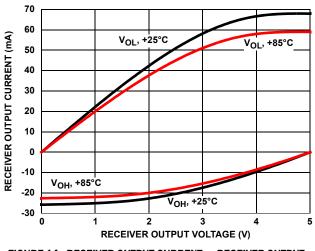


FIGURE 14. RECEIVER OUTPUT CURRENT VS RECEIVER OUTPUT VOLTAGE

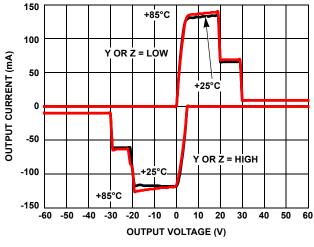


FIGURE 15. DRIVER OUTPUT CURRENT vs SHORT-CIRCUIT VOLTAGE

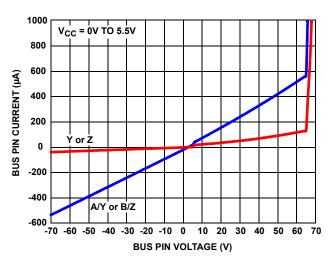


FIGURE 16. BUS PIN CURRENT vs BUS PIN VOLTAGE

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Typical Performance Curves v_{CC} = 5V, T_A = +25°C; Unless Otherwise Specified. (Continued)

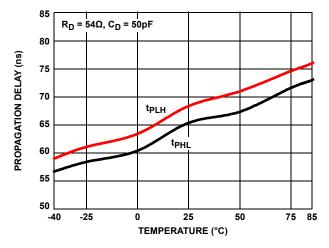


FIGURE 17. DRIVER DIFFERENTIAL PROPAGATION DELAY vs TEMPERATURE

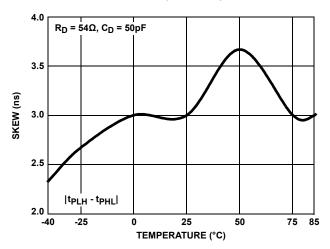


FIGURE 18. DRIVER DIFFERENTIAL SKEW vs TEMPERATURE

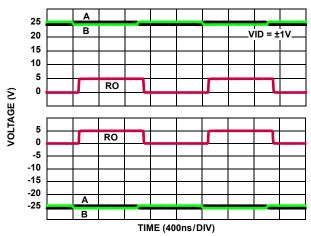


FIGURE 19. RECEIVER PERFORMANCE WITH ±25V CMV

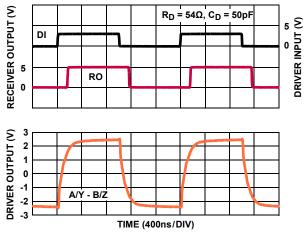


FIGURE 20. DRIVER AND RECEIVER WAVEFORMS

Die Characteristics

SUBSTRATE POTENTIAL (POWERED UP):

GND

PROCESS:

Si Gate BiCMOS

Revision History

The revision history provided is for informational purposes only and is believed to be accurate, but not warranted. Please go to web to make sure you have the latest Rev.

DATE	REVISION	CHANGE
May 13, 2015	FN7785.3	-Figure 3 on page 4: Changed the title from "ISL34183E" to "ISL32483E "Thermal Information" on page 5 changes are: * 14 Ld SOIC Package: Changed Theta-ja: From 88 to 78 and Theta-jc from 39 to 42. *8 Ld SOIC Package: Changed Theta-ja: From 108 to 104 Changed "MAX" on "Driver Differential Rise or Fall Time" on page 6 from 400 to 550.
October 28, 2014	FN7785.2	On p6, in the "Driver Switching Characteristics" section, "Driver Differential Output Skew" parameter, in the second "Test Conditions" line, added "(Note 18)" after the -25V ≤ Vcm ≤ 25V" entry. And on p7, added a new Note 18 to the notes section saying, "This parameter is not production tested." Updated POD M8.15 to most recent version with following changes: Changed in Typical Recommended Land Pattern the following: 2.41(0.095) to 2.20(0.087) 0.76 (0.030) to 0.60(0.023) 0.200 to 5.20(0.205) Changed Note 1 "1982" to "1994"
March 8, 2012	FN7785.1	Page 5 - Thermal Resistance - 8 Ld SOIC package Theta JA changed from 116 to 108 Page 13 - Updated Figure 16 to show Pos breakdown between 60V and 70V.
January 18, 2011	FN7785.0	Initial Release

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Intersil Corporation is a leading provider of innovative power management and precision analog solutions. The company's products address some of the largest markets within the industrial and infrastructure, mobile computing and high-end consumer markets.

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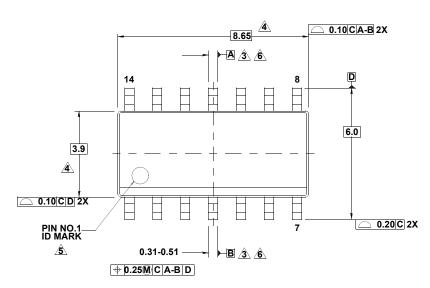
For information regarding Intersil Corporation and its products, see www.intersil.com

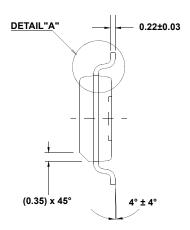
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Package Outline Drawing

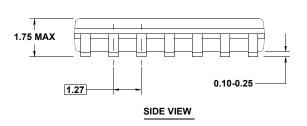
M14.15

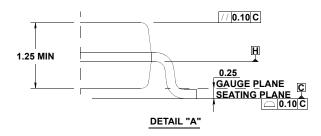
14 LEAD NARROW BODY SMALL OUTLINE PLASTIC PACKAGE Rev 1, 10/09

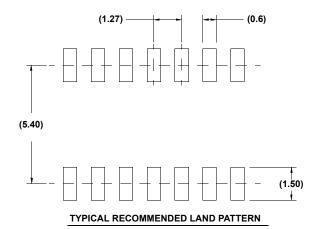




TOP VIEW







NOTES:

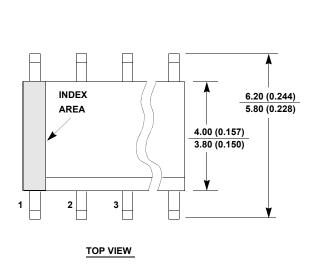
- 1. Dimensions are in millimeters. Dimensions in () for Reference Only.
- 2. Dimensioning and tolerancing conform to AMSEY14.5m-1994.
- 3. Datums A and B to be determined at Datum H.
- 4. Dimension does not include interlead flash or protrusions. Interlead flash or protrusions shall not exceed 0.25mm per side.
- 5. The pin #1 indentifier may be either a mold or mark feature.
- 6. Does not include dambar protrusion. Allowable dambar protrusion shall be 0.10mm total in excess of lead width at maximum condition.
- 7. Reference to JEDEC MS-012-AB.

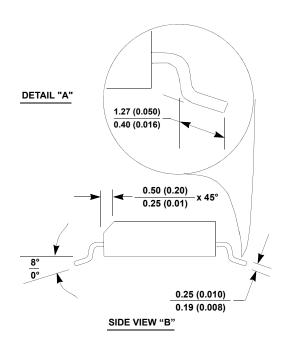
Submit Document Feedback 16 intersil FN7785.3

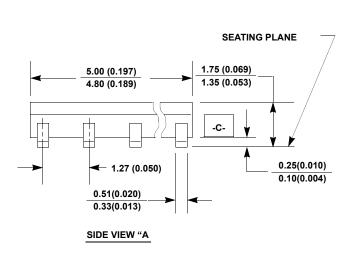
Package Outline Drawing

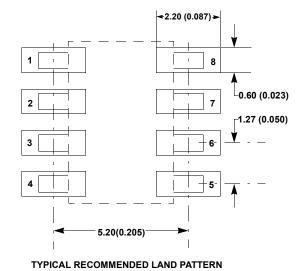
M8.15

8 LEAD NARROW BODY SMALL OUTLINE PLASTIC PACKAGE Rev 4, 1/12









NOTES:

- 1. Dimensioning and tolerancing per ANSI Y14.5M-1994.
- Package length does not include mold flash, protrusions or gate burrs.
 Mold flash, protrusion and gate burrs shall not exceed 0.15mm (0.006 inch) per side.
- 3. Package width does not include interlead flash or protrusions. Interlead flash and protrusions shall not exceed 0.25mm (0.010 inch) per side.
- 4. The chamfer on the body is optional. If it is not present, a visual index feature must be located within the crosshatched area.
- 5. Terminal numbers are shown for reference only.
- The lead width as measured 0.36mm (0.014 inch) or greater above the seating plane, shall not exceed a maximum value of 0.61mm (0.024 inch).
- Controlling dimension: MILLIMETER. Converted inch dimensions are not necessarily exact.
- 8. This outline conforms to JEDEC publication MS-012-AA ISSUE C.

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